

SVC-300 – corrosion issue. Dell Materials Science Laboratory Global Supply Chain Quality Engineering

Report 7568 Materials Analysis

Executive Summary

Dell IPS requested analysis of the SVC-300 midplane assembly with suspected residue on the PCBA surface. Sample was sent to the Material Science Lab (MSL) for an analysis.

Inspection of the SVC-300 midplane assembly revealed extensive corrosion of the midplanes PCBA components, multiple exposed vias, SAS connector terminations and SAS connector pins. Inspection revealed high accumulation of particulate matter residue accumulated in multiple areas of the PCBA assembly. Highly corrosive Sodium Chloride (NaCl) crystals embedded into the assembly PCBA components as well as corrosion byproducts in presents of green residue observed in multiple areas of the midplane PCBA assembly. Corrosion co-product observed on PCBA surfaces were 'metal salts' (mostly hydrates of Copper (II) Chloride) which does have very good solubility in water, what may have led to situation that in environment with elevated humidity those 'metal salts' creates highly conductive debris, which may have led to electrical short conditions and by that could have contributed to the failure observed at customer site. Combined hygroscopic properties of 'salts' identified on the assemblies PCBA surface reates severe risk to existing DELL equipment (on site) of failures if exposed to such a harsh environment.

Hardware Description

| WWFA | Description | Part Number | Serial Number | Supplier |
|------|---------------------------|-------------|-------------------|----------|
| N/A | SVC-300 midplane assembly | 0G6JCT | MTC007AD-GHRX-A00 | GX N-H |
| N/A | SVC-300 midplane assembly | 09798G | MTC007AA-GJ34-A00 | GX N-H |

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Results

Photo 1. Representative overview and manufacturing details of the SVC-300 midplane assembly.



Photo 2. Representative image of the SVC-300 midplane assembly with evidence of corrosion visible without disassembling the device.



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Photo 3. Representative images of the SVC midplane board assembly areas impacted by corrosion.

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Photo 6. Scanning Electron Microscopy (SEM) & Energy Dispersive X-ray (EDX) analysis of a crystallic debris sample extracted from the midplane surface. The main elements detected were: Sodium (Na) and Chloride (Cl).



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Photo 7. Scanning Electron Microscopy (SEM) & Energy Dispersive X-ray (EDX) analysis of a green debris sample extracted from the midplane surface. The main elements detected were: Copper (Cu), Chloride (Cl) and Oxygen (O).



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Ion Chromatography

The overall levels of surface contamination in μ g/in² for each anion detected are tabulated in Table 1 below.



Table 1.

| Description | | | | | | | | | |
|------------------|----------|----------|---------|---------|-----------|----------|-------|--|--|
| Description | Fluoride | Chloride | Bromide | Nitrate | Phosphate | Sulphate | WOA | | |
| Board 1 S1 | 22.7 | 130.8 | ND | 565.2 | 11.1 | 196.7 | 198.7 | | |
| Board 1 S2 | 37.9 | 732.2 | ND | 978.2 | 18.1 | 664.3 | 249.5 | | |
| Allowable limits | 1* | 3* | 7* | 3* | 3* | 3* | 25* | | |

Localized/secondary sample extraction was performed, 0.2 in² areas surrounding components were washed with use of 10ml of DI water at 80°C for each sample.

Samples extraction positions: SP SN: MTC007AD-GHRX-A00: Reference sample extracted around ref des R1152 B1 S1 – ref des R1169 B1 S2 – ref des SAS_11

* EMC-ES-1027 Rev A04. Specification Allowable Limits for Assemblies, ND – not detected



Analysis

- Inspection of the SVC-300 midplane assembly revealed extensive corrosion of the midplanes PCBA components, multiple exposed vias, SAS connector terminations and SAS connector pins.
- Inspection revealed high accumulation of particulate matter residue accumulated in multiple areas of the PCBA assembly.
- Analysis revealed highly corrosive Sodium Chloride (NaCl) crystals embedded into the assembly PCBA components as well as corrosion byproducts in presents of green residue observed in multiple areas of the midplane PCBA assembly.
- Corrosion co-product observed on PCBA surfaces were 'metal salts' (mostly hydrates of Copper (II) Chloride) which does have very good solubility in water, what may have led to situation that in environment with elevated humidity those 'metal salts' creates highly conductive debris, which may have led to electrical short conditions and by that could have contributed to the failure observed at customer site.